

# Transistor Testers

520C



## Model 520C

## **Industrial Transistor Tester**

The B+K Precision model 520C Transistor
Tester is designed for in-circuit and out-of
circuit transistor testing with special features for
making additional tests on devices out-of circuit.
The instrument is designed for a minimum amount of
control manipulation, making for rapid testing of most devices.

- ■Determines good or bad transistors, FET's, SCR's, or diodes.
- Patented limited-energy pulse circuit permits in-circuit testing in the presence of low shunt impedance's with complete safety for the device under test.
- Easy to operate panel eliminates the need to refer to a reference or operating manual-only three switches, no panel adjustments.
- ■Six position test switch makes it unnecessary to know the device terminal identification.
- A LED array identifies leakage in both Silicon and Germanium devices.
- Front Panel socket for out-of -circuit transistor testing.

#### Model 510A

#### **Portable Transistor Tester**

The model 510A performs Good/Bad test for transistors, FET's, and SCR's. It also identifies NPN or PNP for transistors, N-channel or P-channel for FET, FET-gate lead, all leads of transistors in LO drive, base lead in HI drive, and all leads of SCR. It uses a patented limited-energy pulse circuit, which provides highly successful in-circuit testing in the presence of low shunt

impedance's with complete safety for the device under test. The instrument is designed for a minimum amount of control manipulation, allowing for rapid test-

**510A** ing of most devices.

- ■Rapid In-circuit and out-of circuit testing
- ■Good/Bad test
- ■NPN or PNP identification for transistors
- ■N-channel or P-channel identification for FET
- ■FET-gate and SCR lead identification
- ■Battery operated (4 x 1.5 AA batteries)

Specif	ications	models
	520C	510A
IN-CIRCUIT TES		
GOOD/BAD TEST	PNP and NPN transisto	ore
GOOD/BAD IEST	FET's. SCR's	
IDENTIFIES	NPN or PNP	NPN or PNP
	FET as N-channel or P-channel	FET as N-channel or
	TET as in-channel of 1-channel	P-channel
	Silicone or germanium transistors	FET-gate lead, all leads of
	transistors in LO drive, base lead	TE1-gate lead, all leads of
	in HI drive all leads of SCR	
	III TH drive all leads of SCK	
OUT-OF-CIRCUI	T TEST	
GOOD/BAD TEST	PNP and NPN transistors	PNP and NPN transistors
	FET's, SCR's	FET's
IDENTIFIES	NPN or PNP	NPN or PNP
	FET as N-channel or P-channel	FET as N-channel or
	Silicone or germanium transistors	P-channel
MEASURES	Reverse leakage	Does not apply
	from 0.1 mA to 9 mA	
AUTOMATIC IN	DICATORS	
AUDIBLE TONE	GOOD	Does not apply
LED	NPN or PNP, Ge or Si	NPN or PNP, Ge or Si
TEST SWITCH	Base or Gate for good transistor	Base or Gate for good
	or FET's	transistor or FET's
METER SCALES	Readable from 0.1 µA to 9 mA	Does not apply
	for Ice leakage, calibrated for silicon	
	and germanium power and signal	
	transistor leakage limits	
ADDITION TEST	CLIDDENITC	
APPLIED TEST ( BASE DRIVE*		2)
COLLECTOR*	250mA (HI), 1mA (LO) 125mA	
TEST REPETITION	10Hz	5Hz
1EST REPETITION	ТОПИ	JUS
IN-CIRCUIT SHI	JNT LIMIT FOR VALID GOOD/BA	AD TEST
RESISTANCE	$> 10\Omega$ (HI), 1.5k $\Omega$ (L)	
CAPACITANCE	<15mF (HI), 0.3mF (LO)	<25mF (HI), 0.3µF (LO)
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GENERAL		
POWER	9V Battery (Supplied)	6VDC from
REQUIREMENT	or optional AC adaptor	4 "AA" batteries
		(not supplied)
OPERATING TEMP	32° to 104°F (0° to 40°C), ≤75% RH	
DIMENSIONS	7.5 x 4.0 x 2.0"	
(HxWxD)	(191 x 102 x 51 mm)	
WEIGHT	I lb. (450g)	



One Year Warranty

SUPPLIED: FP-6 Semiconductor Test Leads (three test leads w/mini-lock clips), Instruction manual, Battery (520C only)
Optional: BE 12 AC adaptor(9VDC)

\* Duty Cycle @8% for 520C, 2% for 510A

